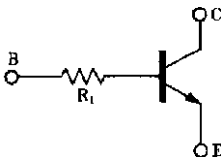


on-chip resistor PNP silicon epitaxial transistor
For mid-speed switching

FEATURES

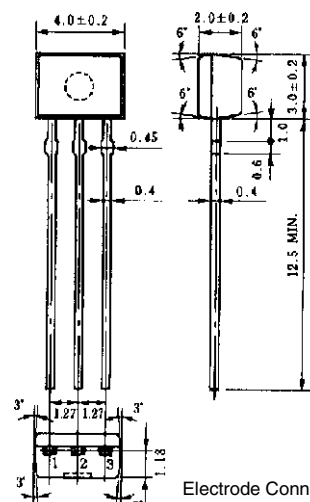
- On-chip bias resistor
($R_1 = 10\text{ k}\Omega$)
- Complementary transistor with BA1A4Z

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	V_{CBO}	60	V
Collector to emitter voltage	V_{CEO}	50	V
Emitter to base voltage	V_{EBO}	5	V
Collector current (DC)	$I_{C(DC)}$	100	mA
Collector current (Pulse)	$I_{C(pulse)}$ *	200	mA
Total power dissipation	P_T	250	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to $+150$	$^\circ\text{C}$

* $PW \leq 10\text{ ms}$, duty cycle $\leq 50\%$

PACKAGE DRAWING (UNIT: mm)



Electrode Connection
1. Emitte
2. Collector
3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = 50\text{ V}$, $I_E = 0$			100	nA
DC current gain	h_{FE1} **	$V_{CE} = 5.0\text{ V}$, $I_C = 5.0\text{ mA}$	135	340	600	—
DC current gain	h_{FE2} **	$V_{CE} = 5.0\text{ V}$, $I_C = 50\text{ mA}$	100	300		—
Collector saturation voltage	$V_{CE(sat)}$ **	$I_C = 5.0\text{ mA}$, $I_B = 0.25\text{ mA}$		0.04	0.2	V
High level input voltage	V_{IL} **	$V_{CE} = 0.2\text{ V}$, $I_C = 5.0\text{ mA}$	2.0	0.8		V
Low level input voltage	V_{IH} **	$V_{CE} = 5.0\text{ V}$, $I_C = 100\text{ }\mu\text{A}$		0.55	0.5	V
Input resistance	R_1		0.7	10	13.0	k Ω
Turn-on time	t_{on}	$V_{CC} = 5.0\text{ V}$, $R_L = 1.0\text{ k}\Omega$			0.2	μs
Storage time	t_{stg}	$V_i = 5.0\text{ V}$, $PW = 2.0\text{ }\mu\text{s}$			5.0	μs
Turn-off time	t_{off}	duty cycle $\leq 2\%$			6.0	μs

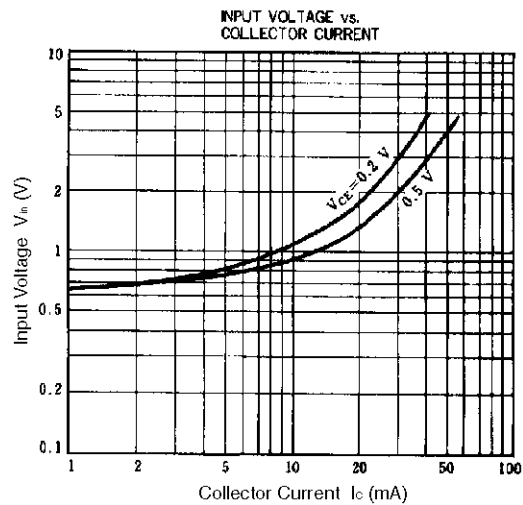
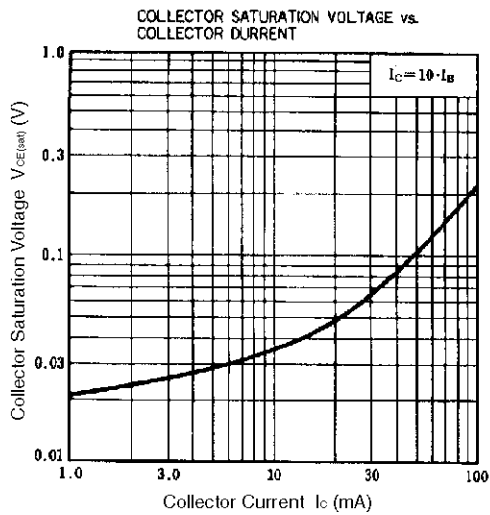
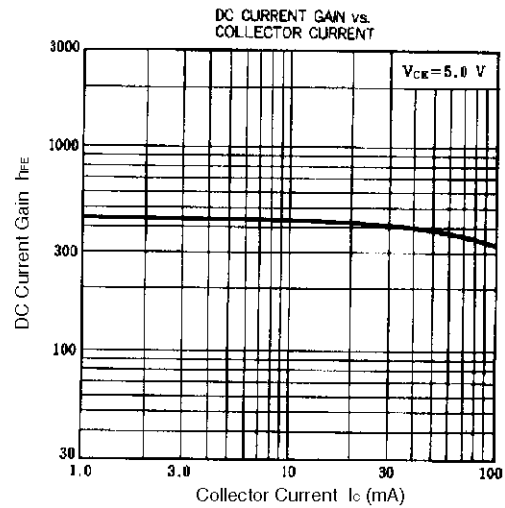
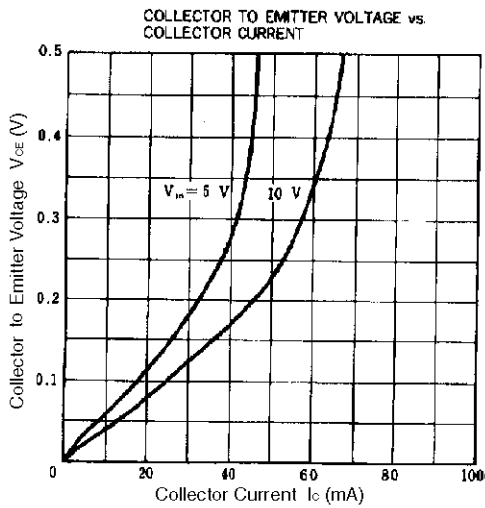
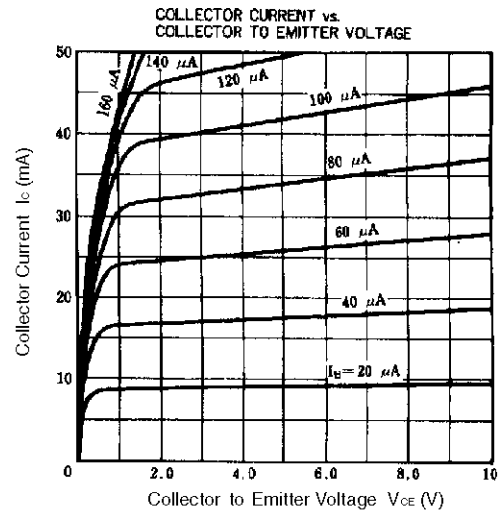
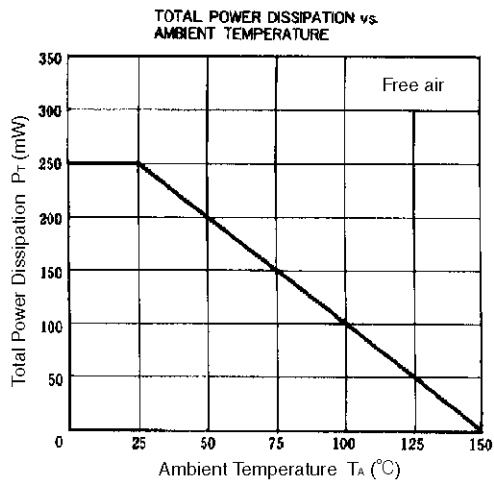
** Pulse test $PW \leq 350\text{ }\mu\text{s}$, duty cycle $\leq 2\%$

 h_{FE} CLASSIFICATION

Marking	Q	P	K
h_{FE1}	135 to 270	200 to 400	300 to 600

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TYPICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)



[MEMO]

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